

TOSHIBA

GT15J121

Preliminary TOSHIBA Insulated Gate Bipolar Transistor Silicon N Chanenel IGBT

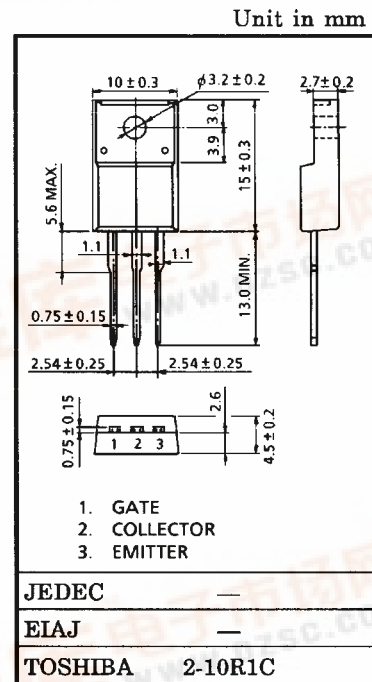
GT15J121

High Power Switching Applications
Fast Switching Applications

- The 4th generation
- Enhancement-mode
- Ultra Fast Switching(UFS :Operating frequency up to 150kHz(Reference)
 - High speed : $t_r=0.03\mu s$ (typ.)
: $t_f=0.08\mu s$ (typ.)
 - Low switching loss : $E_{on}=0.23mJ$ (typ.)
: $E_{off}=0.18mJ$ (typ.)

Maximum Ratings (Ta=25°C)

Characteristic	Symbol	Ratings	Unit
Collector-emitter voltage	V_{CES}	600	V
Gate-emitter voltage	V_{GES}	± 20	V
Collector current	DC	I_C	15
	1ms	I_{CP}	45
Collector power dissipation (Tc=25°C)	P_C	35	W
Junction temperature	T_j	150	°C
Storage temperature range	T_{stg}	-55~150	°C



Weight : 1.7g

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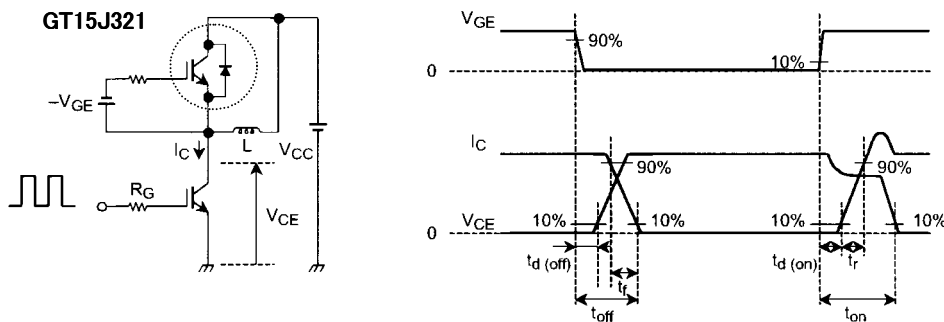


Preliminary

Electrical Characteristics(Ta=25°C)

Characteristic		Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current		I_{GES}	$V_{GE}=\pm 20V, V_{CE}=0$	-	-	± 500	nA
Collector cut-off current		I_{CES}	$V_{CE}=600V, V_{GE}=0$	-	-	1.0	mA
Gate-emitter cut-off voltage		$V_{GE(OFF)}$	$I_C=1.5mA, V_{CE}=5V$	3.0	-	6.0	V
Collector-emitter saturation volatage		$V_{CE(sat)}$	$I_C=15A, V_{GE}=15V$	-	2.7	3.5	V
Input capacitance		C_{ies}	$V_{CE}=10V, V_{GE}=0, f=1MHz$	-	1300	-	pF
Switching time	Turn-on delay time	$t_{d(on)}$	Inductive Load $V_{CC}=300V, I_C=15A$ $V_{GG}=\pm 15V, R_G=27\Omega$ (Note 1) (Note 2)	-	0.04	-	μs
	Rise Time	t_r		-	0.03	-	
	Turn-on Time	t_{on}		-	0.12	-	
	Turn-off delay time	$t_{d(off)}$		-	0.10	-	
	Fall Time	t_f		-	0.08	0.15	
	Turn-off Time	t_{off}		-	0.20	-	
Switching loss	Turn-on switching loss	E_{on}	-	0.23	-	mJ	
	Turn-off switching loss	E_{off}	-	0.18	-		
Thermal resistance		$R_{th(j-c)}$	—	-	-	3.57	°C/W

Note 1: Switching time measurement circuit and input/output waveforms



Note 2: Switching loss measurement waveforms

